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Pyrolytic 3D Carbon Microelectrodes for Electrochemistry
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This work presents the fabrication and characterization of suspended three-dimensional (3D) pyrolytic carbon microelectrodes for electrochemical applications. For this purpose, an optimized process with multiple steps of UV photolithography with the negative tone photoresist SU-8 followed by pyrolysis at 900°C for 1h was developed. With this process, microelectrode chips with a three electrode configuration were fabricated and characterized with cyclic voltammetry (CV) using a 10mM potassium ferri-ferrocyanide redox probe in a custom made batch system with magnetic clamping. The 3D pyrolytic carbon microelectrodes displayed twice the higher peak current compared to 2D.

Introduction

Carbon materials have several attractive characteristics for microelectrodes in electrochemical applications, such as a wide potential window, good electrochemical activity, chemical stability, and ease in surface functionalization (1). The most common carbon microfabrication techniques (i.e. screen printing) produce two-dimensional (2D) electrodes. However, 3D microelectrodes provide larger surface area and thereby could enhance the sensitivity in electrochemical detection (2). Hence, several 3D microfabrication techniques have been explored amongst which the carbon MEMS (C-MEMS) approach is the most promising one for the fabrication of conductive 3D microstructures. In C-MEMS, a patterned polymer template is treated at high temperature (~900°C) in inert atmosphere (N\textsubscript{2} or Ar) and transformed into pyrolytic carbon. This process enables fabrication of 2D and 3D electrodes with the possibility to tailor designs and thereby sensitivities for electrochemical sensing applications. Due to this, pyrolytic carbon microelectrodes are becoming increasingly attractive for numerous applications, such as in novel sensors and scaffolds for cell monitoring (3–5). Nevertheless, fabrication of electrically conductive 3D carbon microelectrodes (3DCMEs) with structural dimensions that are comparable to the size of biological cells still remains challenging.

One of the most important factors in 3D C-MEMS technology is the definition of a mechanically stable 3D polymer precursor template for pyrolysis. Recently, various 3D polymer fabrication technologies evolved. Microfabrication methods such as two-photon, e-beam and X-ray lithography proved to be powerful tools in developing 3D micro/nanostructures but unfortunately still display a very low throughput and the required equipment is rather expensive (6,7). Some of the additive manufacturing technologies such as 3D printing or stereolithography provide a higher throughput but lack the micron range resolution (8). Therefore, in most C-MEMS processes, polymer microstructures were fabricated using standard UV photolithography with the chemically enhanced, negative tone epoxy photoresist SU-8 (9–11). This method is readily available
at a reasonable cost. Typically, SU-8 photolithography comprises spin coating, solvent evaporation, UV-exposure, polymerization and development (12,13). Each of these steps affect the photolithographic resolution and the properties of SU-8 structures such as stress or adhesion to the substrate. Therefore, depending on the desired application different process parameters have to be optimized to obtain well-resolved and mechanically stable 3D microstructures (14).

Different fabrication processes have been proposed to obtain suspended SU-8 microstructures. The most common process involves adding a polymerization-stop-layer between the structures to be suspended and the substrate (15). The complexity of this fabrication process increases as the structures become multilayered (i.e. more 3D). Another method includes doping of the SU-8 photoresist with nanoparticles to control the thickness of freestanding 3D structures (11). However, such an addition of Fe$_2$O$_3$ nanoparticles requires a number of preparation steps which severely limit the flexibility of the process. The most promising processes to define suspended layer so far are using a partial UV exposure of SU-8 photoresist films either at a lower wavelength (313nm) or/and a very low dose (15,16).

In this work, we developed a multi-step UV photolithography process to fabricate a 3D SU-8 polymer template which was pyrolyzed to define 3D carbon microelectrodes for electrochemistry. The fabrication of suspended microstructures in a single layer of SU-8 was optimized. The process was used to define 3D carbon microstructures acting as the working electrodes (WE) in microelectrode chips with a three electrode configuration. The electrochemical performance of 2D and 3D carbon microelectrodes was compared with cyclic voltammetry (CV) in a batch system with 10mM potassium ferri-ferrocyanide standard redox probe.

**Methods**

**Microelectrode chips**

The microelectrode chips were fabricated with multiple steps of UV photolithography followed by pyrolysis as shown schematically in Figure 1.a - e. First, the process of fabricating suspended layers from a single layer of SU-8 was optimized by adjusting the partial exposure dose ($D_3$) (16). The optimized process was used to fabricate 3DCMEs on the working electrode of the microelectrode chips. Figure 1.f and g shows the top view of the microelectrode chip without and with passivation layer (SU-8). The process is explained along the cross-section AA' (Figure 1.f).

Approximately 5 ml of negative photoresist (SU-8 2005 from MicroChem, USA) were manually dispensed on a 4-inch Si/SiO$_2$ substrate and spin coated (RCD8 T, Süss MicroTec, Germany) to deposit a 6µm thick layer. A solvent evaporation for 2h at room temperature was followed by a UV exposure step with an exposure dose, $D_1= 147$ mJcm$^{-2}$ in an EVG620 aligner (EVGroup, Austria) to define the working and counter electrodes (Figure 1.a) (13). The aligner was equipped with a mercury lamp and a long pass filter (SU-8 filter), adjusted to a constant intensity of 7 mWcm$^{-2}$ at 365 nm. This is followed by a post-exposure bake (PEB) at 50 °C for 1 h on a programmable hotplate (Harry Gestigkeit GmbH, Germany). A second layer of SU-8 2075 was manually dispensed and
spin coated to a thickness of 66µm. The edge bead was removed by dispensing propylene glycol methyl ether acetate (PGMEA) at the edge of the rotating wafer (300 rpm). A soft bake (SB) at 50 ºC for 6h is followed by a two-step UV photolithography to achieve 3D microstructures. The first exposure \( (D_2 = 147 \text{ mJcm}^{-2}) \) defines the supporting pillars (Figure 1.b) and the partial exposure \( (D_3) \) defines the suspended layer (Figure 1.c). \( D_3 \) was optimized to limit the crosslinking to the top of the SU-8 layer. This was followed by a PEB at 50 ºC for 8 h. Development was performed in PGMEA in two steps of 10 min followed by isopropanol rinse for 30 s and drying in air (Figure 1.d). Next, an additional flood exposure with a total dose \( D = 500 \text{ mJcm}^{-2} \) and a hard-bake at 90 ºC for 15 h were performed to increase the structural stability of SU-8 achieved by improved crosslinking. The polymer template is pyrolyzed in an ATV PEO604 furnace (ATV Tech., Germany) in inert atmosphere (N\(_2\)) in two steps, 200 ºC for 30 min and 900 ºC for 1h with a ramp of 2 ºmin\(^{-1}\) to produce suspended carbon microstructures.

Figure 1. Schematic of the microfabrication process (a) SU-8 (2005) is spin coated, baked UV exposed and post exposure baked (b) Second layer of SU-8 (2075) is spin coated, baked and UV exposed (c) short UV exposure and post exposure bake (d) Development in PGMEA (e) Pyrolysis at 900ºC for 1h and e-beam Au deposition through a shadow mask (f) and (g) shows the top view of the microelectrode chip without and with passivation (SU-8) layer
A gold pseudo-reference electrode and gold contact pads were deposited by e-beam evaporation through a shadow mask (Figure 1.e). For passivating the contact leads, a 2µm thick film of SU-8 2002 was spin coated and patterned as described above for the SU-8 2005 including the final flood exposure and hard bake.

**Batch system with magnetic clamping**

A self-aligning, magnetic clamping system was developed for electrochemical characterization of the microelectrode chips. Figure 2 shows the schematic of different layers in the batch system. Rare earth magnets were used to facilitate clamping and exchange of the microelectrode chips. A CO$_2$ laser (Epilog Laser, USA) was used for drilling and dicing of the PMMA parts followed by bonding them using pressure sensitive adhesive (PSA) in a bonding press (P/O Webber, Germany) at 35ºC with a pressure of 150 bar for 10 min. The top plate defines a circular well with diameter 8 mm above the electrode area suitable for experiments in batch conditions. Furthermore, a trench was engraved in the top plate accommodating an O-ring to avoid any leakage in the cavity. The bottom plate provided the slot for placing the microelectrode chips.

![Figure 2. Different components in the magnetically clamped batch system](image)

**Electrochemical Characterisation**

For electrochemical analysis, cyclic voltammetry (CV) was performed using a standard 10 mM potassium ferri-ferrocyanide redox probe in the batch systems. The microelectrode chips (2D and 3D) were pretreated in O$_2$ plasma (Electronic Diener, Germany) at 50W for 60 seconds. Then the chips were placed in the bottom plate of the batch system and sealing was achieved with the O-ring of the top plate. 350 µL of redox
probe were pipetted on the electrode for each measurement. For CV, a voltage of -0.6 V to +0.6 V in steps of 100 mV was applied with a Potentiostat (Autolab PGSTAT302N, Netherlands).

**Results and Discussion**

**Microfabrication of electrodes**

The optimization of the partial exposure dose ($D_3$) is critical for the fabrication of 3D suspended SU-8 microstructures. Therefore, an initial series of experiments on various test structures was performed using a single layer of SU-8 and two UV exposures ($D_2$ and $D_3$). Very low exposure doses $D_3$ were selected, in the attempt to achieve a gradient in the concentration of activated photoinitiator molecules in the SU-8 film. The exposure dose $D_3$ was varied from 21 - 42 mJcm$^{-2}$. The results of the optimization of the partial exposure are shown in Figure 3. The exposure dose, $D_3 = 21$ mJcm$^{-2}$ is insufficient for the crosslinking of the top layer of SU-8 film. Hence, after the development in PGMEA only SU-8 pillars from the long UV exposure process remain (Figure 3.a). A higher exposure dose of $D_3 = 28$ mJcm$^{-2}$ limits the crosslinking to the top surface of the SU-8 film, which results in suspended 3D structures (Figure 3.b). The thickness of the suspended layer is 18 µm. Higher dose ($D_3 = 35$ mJcm$^{-2}$ and 42 mJcm$^{-2}$) causes complete crosslinking of the SU-8 film (Figure 3.c, d). These results are in agreement with those obtained by Lim et al. and demonstrate that the process window in terms of exposure dose is very narrow requiring precise control of the exposure conditions (16).

![Figure 3. Optimization of partial UV exposure ($D_2$) with different exposure dose $D_2$: (a) 21 mJcm$^{-2}$; (b) 28 mJcm$^{-2}$; (c) 35 mJcm$^{-2}$; (d) 42 mJcm$^{-2}$ (Scale bar – 25µm)](image-url)
The two steps of UV exposure followed by pyrolysis result in 3D carbon microstructures with various feature sizes (Figure 4). Figure 4 illustrates the carbon microstructures obtained through pyrolysis of the SU-8 template and shows the large shrinkage during pyrolysis. The final height of the structures was 37 µm and the thickness of the suspended carbon film was approximately 2.4 µm. The smallest feature size fabricated in the suspended layer was approximately 5.6 µm as shown in Figure 4.d. The results show that once the structures are defined in SU-8, the overall design of the 3D microstructures are maintained during pyrolysis even though a considerable shrinkage is observed. The optimized process was transferred to the fabrication of the complete microelectrode chip as described in figure 1. Figure 5.a and b shows 2D and 3D working electrodes obtained respectively. And Figure 5 c shows SEM image of working electrode in a 3D microelectrode chip (Figure 5. b).

Figure 4. SEM images of (a) and (b) SU-8 polymer template; (c) and (d) are the corresponding carbon microstructures respectively (Scale bar – 25µm)

Figure 5. Microelectrode chips (a) 2D working electrode (b) 3D working electrode (c) SEM image of 3D working electrode
Electrochemical characterization

Figure 5. a and b show the two different microelectrode designs characterized with CV in the magnetically clamped batch systems. The experimental step-up is shown in Figure 6.a. Figure 6.b shows the mean values and the standard deviation obtained with three microelectrode chips of each design. The peak current ($I_p$) of 2D and 3D chips are 29µA and 57µA respectively and the peak separation ($\Delta E_p$) is 0.3 V and 0.24V for 2D and 3D chips respectively.

![Image of experimental setup and CV graphs showing 2D and 3D microelectrode chips with magnetic clamp and PMMA holder.](image.png)

Figure 6. (a) Experimental set-up, (b) CV of 2D and 3D microelectrode chips

The surface area of the working electrode on the 3D microelectrode chips is approximately 3.5 times larger than for the 2D WE. This explains the higher current when compared to 2D electrodes.

Conclusion

SU-8 templates with suspended features in the micrometer range were successfully fabricated and pyrolyzed to obtain microelectrode chips with 3D carbon microelectrodes as working electrode. A two-step ($D_2$ and $D_3$) UV exposure was optimized to fabricate the suspended layer. Small variations of the partial exposure dose $D_3$ result in complete/no crosslinking of the SU-8 layer, demonstrating the narrow window for $D_3$. The higher signal in CV for 3D microelectrode chips demonstrates an increase of the surface area compared to the 2D configuration which should result in a higher sensitivity for electrochemical sensing. With unique properties of carbon, the proposed fabrication process can be used to customize ad-hoc carbon microelectrodes for specific applications such as biosensors.

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